

## Pyrex玻璃的ICP刻蚀技术研究

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摘要:

以SF<sub>6</sub>/Ar为刻蚀气体,采用感应耦合等离子体(ICP)刻蚀Pyrex玻璃,研究气体流量、射频功率对刻蚀速率及刻蚀面粗糙度的影响。采用正交实验方法找出优化的实验参数,得到Pyrex玻璃刻蚀速率为106.8nm/min,表面粗糙度为Ra=5.483nm,实验发现增加自偏压是提高刻蚀速率、减小刻蚀面粗糙度的有效方法。

关键词: ICP刻蚀, MEMS, Pyrex玻璃,实验设计

## Study on the ICP Etching Technology for Pyrex glass

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**Abstract:**

Inductively Coupled Plasma Etching Technology of Pyrex glass etched by SF<sub>6</sub>/Ar. The important parameters, such as the flow of SF<sub>6</sub>/Ar, ICP source power, substrate power that affect the etching rate and roughness of glass are analyzed. Perpendicular experimentation is used in the experiment. An etch rate of 106.8nm/min With a surface roughness of 5.483nm is obtained. In the experiment, increasing self-bias voltage is an efficient method to improve the etching rate and surface roughness.

**Keywords:** ICP etching, MEMS, Pyrex glass, design of experiment

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